Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | TANAKA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,954,320	09-1990	Birmingham et al.	422/186.04
	В	US-5,801,489	09-1998	Chism et al.	315/111.21
	С	US-6,455,014	09-2002	Hammerstrom et al.	422/186.04
	D	US-6,811,757	11-2004	Niv et al.	422/186.04
	E	US-6,818,193	11-2004	Christodoulatos et al.	423/210
	F	US-2001/0043890	11-2001	Son, Geon Seog	422/174
	G	US-2004/0050684	03-2004	Babko-Malyi et al.	204/164
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08-155249	06-1996	Japan	Tetsuya et al.	B01D 53/32
	0	JP 09-000869	01-1997	Japan	Koichi et al.	B01D 53/56
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

NON-FATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V		3 20 20 20					
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.